

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/695,379	XIAO ET AL.
	Examiner	Art Unit
	B. Chen	1762

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
427	255.29	5/23/2006	BC
	255.393		
	255.394		